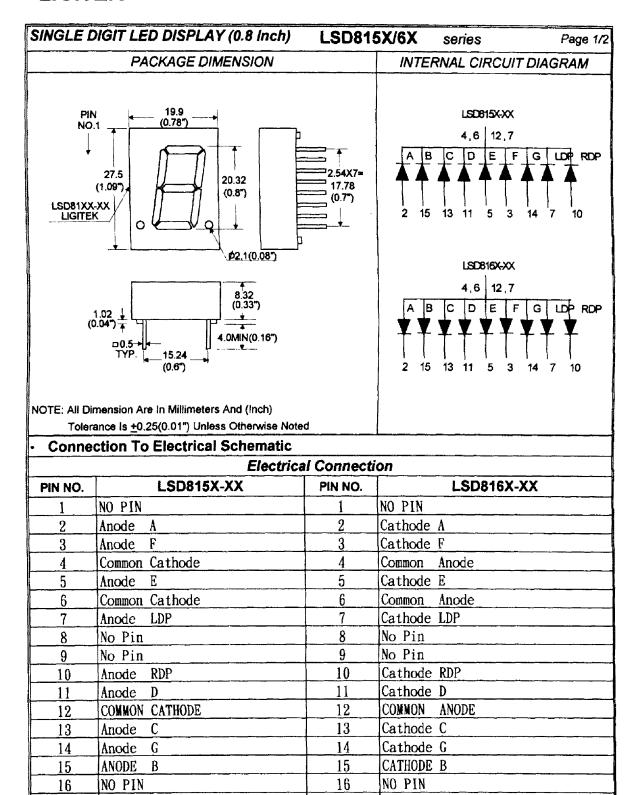
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文件编號:QW0905-S815/6X-XX

Common Cathode

No Pin

17

18 版本:A

17

Common Anode

No Pin

生效日期: Jun. 8. 1996

Part Selection And Application Information (Ratings At 25°C Ambient)

	OUED		common cathode	λР	Δλ	Electrical					
PART NO	CHI	P	or anode	(nm)	(nm)		Vf(v)		lv(n	ncd)	IV-M
	material	emitted				Min	Тур.	Max	Min	Тур.	
LSD8155-XX	GaAlAs	Red		660	20	1.5	1.7	2.4	2.4	4.0	2:1
LSD8151-XX	GaP	Red	Common	697	90	1.7	2.1	2.8	0.6	1.0	2:1
LSD8152-XX	GaP	Green	Cathode	565	30	1.7	2.1	2.8	1.8	3.0	2:1
LSD8153-XX	GaAsP/GaP	Yellow]	585	35	1.7	2.0	2.8	1.6	2.7	2:1
LSD8154V-XX	GaAsP/GaP	Orange		635	45	1.7	2.0	2.8	2.2	3.9	2:1
LSD8165-XX	GaAlAs	Red	- Common Anode	660	20	1.5	1.7	2.4	2.4	4.0	2:1
LSD8161-XX	GaP	Red		697	90	1.7	2.1	2.8	0.6	1.0	2:1
LSD8162-XX	GaP	Green		565	30	1.7	2.1	2.8	1.8	3.0	2:1
LSD8163-XX	GaAsP/GaP	Yellow		585	35	1.7	2.0	2.8	1.6	2.7	2:1
LSD8164V-XX	GaAsP/GaP	Orange		635	45	1.7	2.0	2.8	2.2	3.9	2:1

Absolute Maximum Rating (Ta=25°C)

Parameter		Red		Green	Yellow	Orange	Unit	Remar
Forward Current Per Chip	SR		Н	PG	Y	VR		
	40		15	30	20	30	mA	
Peak Current Per Chip (Duty 1/10, 0.1MS Pulse Width)	200		60	120	80	120	mA	
Power Dissipation Per Chip	11	0	45	100	85	100	mW	
Derating Linear From 25°C Per Chip	0.4	15 0	. 25	0.45	0.45	0.45	mA/ °C	
Reverse Current Per Any Chip	10		10	10	10	μА		
Operating Temperature				-2	5°C TO +85°	_l	L	
Storage Temperature				-2	5°C TO +85°	C C		

Solder Temperature 1/16 Inch Below Seating Plane For 3 Seconds At 260°C

Test Condition For Each Parameter

Parameter	Symbol	Unit	Test Condition	
Forward Voltage Per Chip	Vf	volt		
Luminous Intensity Per Chip	Iv	mcd	If=10mA	
Peak Emission Wavelength	λP	nm	lf=20mA	
Spectral Line Half-Width	Δλ	nm	lf=20mA	
Reverse Current Any Chip	Ir	μА	Vr=5V	
Luminous Intensity Matching Ratio	IV-M			